Search Notes

Application/Control No.
10/600,203
Examiner

Applicant(s)/Patent under Reexamination

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Art Unit

Khiem D. Nguyen

2823

SEARCHED				
Class	Subclass	Date	Examiner	
438	118	6/28/2006	K.N.	
438	406	6/28/2006	K.N.	
438	455-459	6/28/2006	K.N.	
438	615-617	6/28/2006	K.N.	
257	625	6/28/2006	K.N.	
257	676	6/28/2006	K.N.	
257	779-783	6/28/2006	K.N.	
257	784-785	6/28/2006	K.N.	
257	E27.137	6/28/2006	K.N.	
257	E27.161	6/28/2006	K.N.	
257	E23.023	6/28/2006	K.N.	
257	E23.077	6/28/2006	K.N.	
428	441, 446	6/28/2006	K.N.	
148	33-33.3	6/28/2006	K.N.	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	6/28/2006	K.N.	